

TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

## TC74HCT86AP, TC74HCT86AF

### Quad Exclusive OR Gate

The TC74HCT86A is a high speed CMOS EXCLUSIVE OR GATE fabricated with silicon gate C<sup>2</sup>MOS technology.

It achieves the high speed operation similar to equivalent LSTTL while maintaining the CMOS low power dissipation.

This device may be used as a level converter for interfacing TTL or NMOS to High Speed CMOS. The inputs are compatible with TTL, NMOS and CMOS output voltage levels.

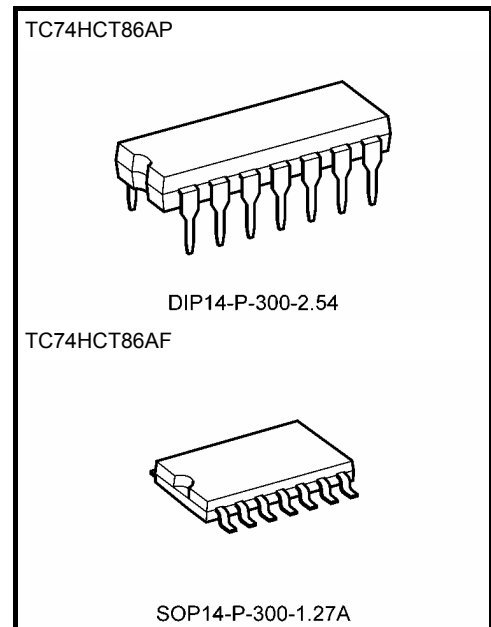
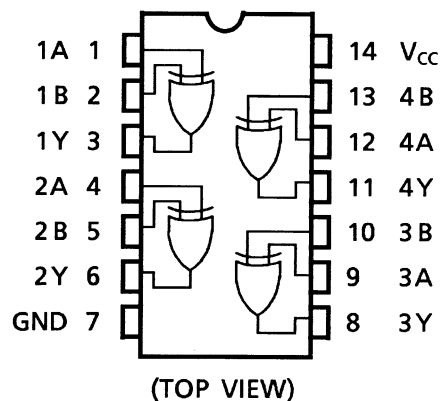
Input and output buffers are provided which offer high noise immunity and stable output.

All inputs are equipped with protection circuits against static discharge or transient excess voltage.

### Features

- High speed:  $t_{pd} = 15 \text{ ns}$  (typ.) at  $V_{CC} = 5 \text{ V}$
- Low power dissipation:  $I_{CC} = 1 \mu\text{A}$  (max) at  $T_a = 25^\circ\text{C}$
- Compatible with TTL outputs:  $V_{IH} = 2.0 \text{ V}$  (min)  
 $V_{IL} = 0.8 \text{ V}$  (max)
- Wide interfacing ability: LSTTL, NMOS, CMOS
- Output drive capability: 10 LSTTL loads
- Symmetrical output impedance:  $|I_{OH}| = I_{OL} = 4 \text{ mA}$  (min)
- Balanced propagation delays:  $t_{pLH} \approx t_{pHL}$
- Pin and function compatible with 74LS86

### Pin Assignment

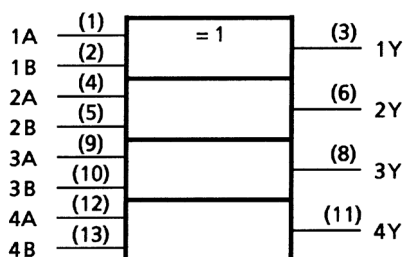


Weight

DIP14-P-300-2.54 : 0.96 g (typ.)

SOP14-P-300-1.27A : 0.18 g (typ.)

## IEC Logic Symbol



## Truth Table

A	B	Y
H	H	L
L	H	H
H	L	H
L	L	L

## Absolute Maximum Ratings (Note 1)

Characteristics	Symbol	Rating	Unit
Supply voltage range	$V_{CC}$	$-0.5 \sim 7$	V
DC input voltage	$V_{IN}$	$-0.5 \sim V_{CC} + 0.5$	V
DC output voltage	$V_{OUT}$	$-0.5 \sim V_{CC} + 0.5$	V
Input diode current	$I_{IK}$	$\pm 20$	mA
Output diode current	$I_{OK}$	$\pm 20$	mA
DC output current	$I_{OUT}$	$\pm 25$	mA
DC $V_{CC}$ /ground current	$I_{CC}$	$\pm 50$	mA
Power dissipation	$P_D$	500 (DIP) (Note 2)/180 (SOP)	mW
Storage temperature	$T_{stg}$	$-65 \sim 150$	$^{\circ}\text{C}$

Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc.).

Note 2: 500 mW in the range of  $T_a = -40$  to  $65^{\circ}\text{C}$ . From  $T_a = 65$  to  $85^{\circ}\text{C}$  a derating factor of  $-10$  mW/ $^{\circ}\text{C}$  shall be applied until 300 mW.

## Operating Ranges (Note)

Characteristics	Symbol	Rating	Unit
Supply voltage	$V_{CC}$	4.5~5.5	V
Input voltage	$V_{IN}$	$0 \sim V_{CC}$	V
Output voltage	$V_{OUT}$	$0 \sim V_{CC}$	V
Operating temperature	$T_{opr}$	$-40 \sim 85$	$^{\circ}\text{C}$
Input rise and fall time	$t_r, t_f$	0~500	ns

Note: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs must be tied to either  $V_{CC}$  or GND.

## Electrical Characteristics

## DC Characteristics

Characteristics	Symbol	Test Condition		Ta = 25°C			Ta = -40~85°C		Unit	
				V <sub>CC</sub> (V)	Min	Typ.	Max	Min		Max
High-level input voltage	V <sub>IH</sub>	—		4.5~5.5	2.0	—	—	2.0	—	V
Low-level input voltage	V <sub>IL</sub>	—		4.5~5.5	—	—	0.8	—	0.8	V
High-level output voltage	V <sub>OH</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OH</sub> = -20 μA	4.5	4.4	4.5	—	4.4	—	V
			I <sub>OH</sub> = -4 mA	4.5	4.18	4.31	—	4.13	—	
Low-level output voltage	V <sub>OL</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OL</sub> = 20 μA	4.5	—	0.0	0.1	—	0.1	V
			I <sub>OL</sub> = 4 mA	4.5	—	0.17	0.26	—	0.33	
Input leakage current	I <sub>IN</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND		5.5	—	—	±0.1	—	±1.0	μA
Quiescent supply current	I <sub>CC</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND		5.5	—	—	1.0	—	10.0	μA
	I <sub>C</sub>	Per input: V <sub>IN</sub> = 0.5 V or 2.4 V Other input: V <sub>CC</sub> or GND		5.5	—	—	2.0	—	2.9	mA

AC Characteristics (C<sub>L</sub> = 15 pF, V<sub>CC</sub> = 5 V, Ta = 25°C, input: t<sub>r</sub> = t<sub>f</sub> = 6 ns)

Characteristics	Symbol	Test Condition	Min	Typ.	Max	Unit
Output transition time	t <sub>TLH</sub>	—	—	6	12	ns
	t <sub>THL</sub>					
Propagation delay time	t <sub>pLH</sub>	—	—	15	23	ns
	t <sub>pHL</sub>					

AC Characteristics (C<sub>L</sub> = 50 pF, input: t<sub>r</sub> = t<sub>f</sub> = 6 ns)

Characteristics	Symbol	Test Condition		Ta = 25°C			Ta = -40~85°C		Unit
				V <sub>CC</sub> (V)	Min	Typ.	Max	Min	Max
Output transition time	t <sub>TLH</sub>	—	4.5	—	8	15	—	19	ns
	t <sub>THL</sub>		5.5	—	7	13	—	16	
Propagation delay time	t <sub>pLH</sub>	—	4.5	—	18	27	—	34	ns
	t <sub>pHL</sub>		5.5	—	16	25	—	31	
Input capacitance	C <sub>IN</sub>	—	—	—	5	10	—	10	pF
Power dissipation capacitance	C <sub>PD</sub> (Note)	—	—	—	26	—	—	—	pF

Note: C<sub>PD</sub> is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

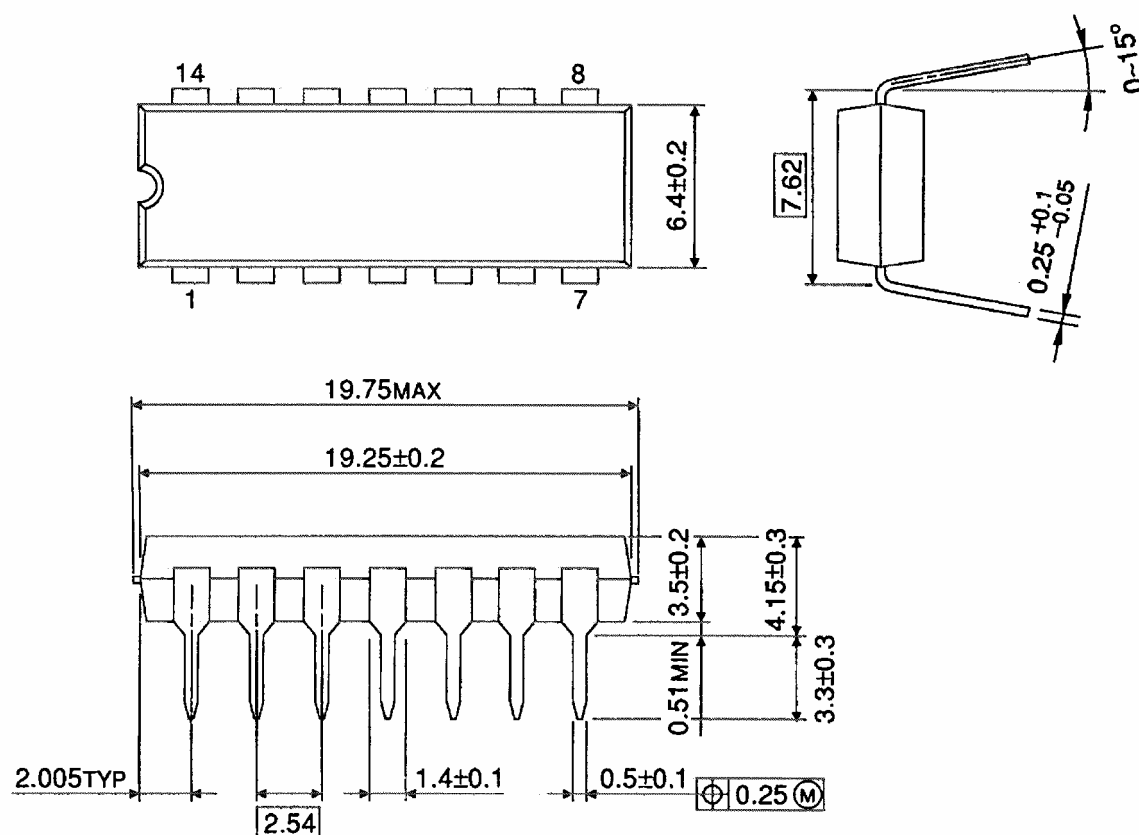
Average operating current can be obtained by the equation:

$$I_{CC}(\text{opr}) = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/4 \text{ (per gate)}$$

## Package Dimensions

DIP14-P-300-2.54

Unit : mm

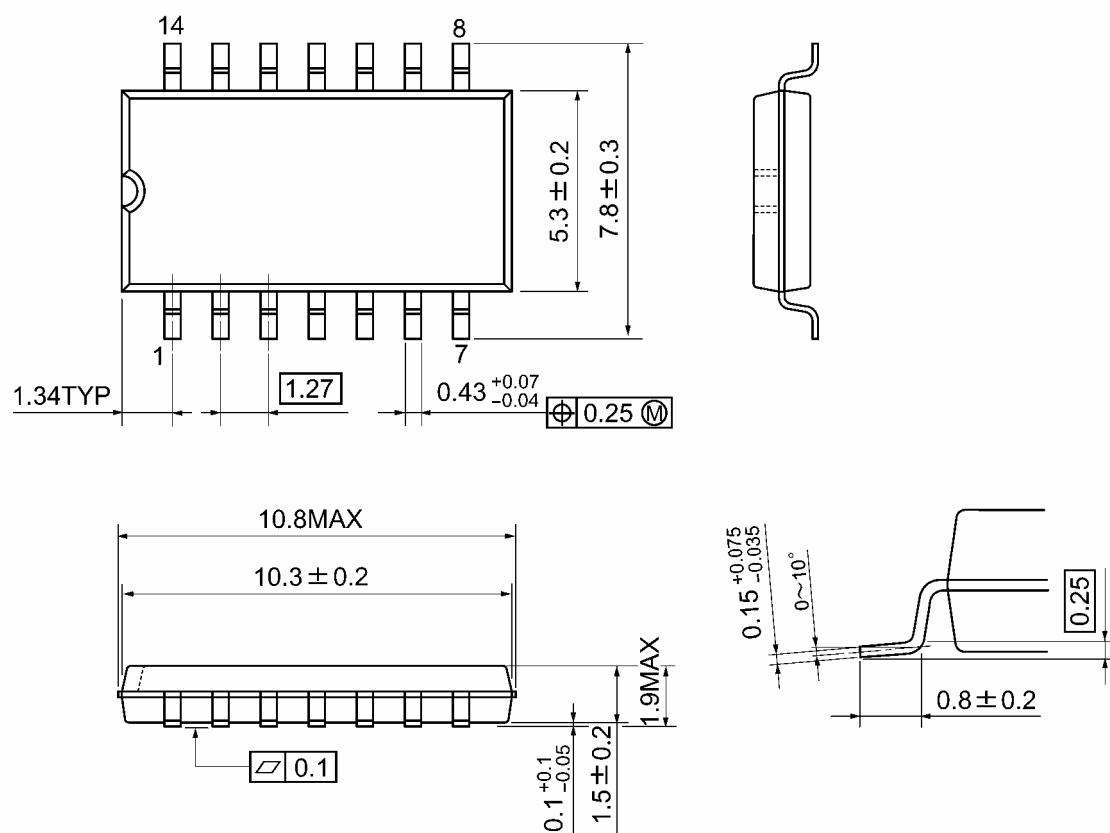


Weight: 0.96 g (typ.)

## Package Dimensions

SOP14-P-300-1.27A

Unit: mm



Weight: 0.18 g (typ.)

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20070701-EN GENERAL

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